

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/789,339	<b>Applicant(s)/Patent under Reexamination</b> NUEBEL ET AL.
<b>Examiner</b> TUYEN T. NGUYEN	<b>Art Unit</b> 2832	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
<i>Same as above</i>		12/22/06	TWN